JAEA-IAEA Workshop on Advanced Safeguards
Technology for the Future Nuclear Fuel Cycle
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# Development of Analytical Techniques for Safeguards Environmental Samples at JAEA as IAEA Network Analytical Laboratory



Research Group for Analytical Science Nuclear Science and Energy Directorate Japan Atomic Energy Agency

#### Contents

- Introduction of safeguards environmental sample analysis (ESA)
  - Objective of ESA in safeguards
  - Technique of ESA
    - Bulk analysis
    - Particle analysis (SIMS method)
    - Particle analysis (FT-TIMS method)
- **♦** Milestone
- Introduction of CLEAR facility

#### Introduction

- Suspicion for North Korea and Iraq in early 1990s
- ◆93+2 Programme to strengthen the international safeguards system
  - Introduction of environmental sample analysis
    - Undeclared nuclear activities
    - Undeclared nuclear materials

### **Environmental sample**



Cotton cloth  $(10x10 cm^2)$ 



Cellulose  $(2.5 \text{cm} \phi)$ 





Wipe wall and floor in a nuclear facility

For example, looking for

High enrichment uranium in enrichment plant Weapon grade plutonium in R&D facility

Isotope ratio of U & Pu



# Laboratory

### **CLEAR**

- Clean room lab.
- Bulk analysis
- Particle analysis
- Non-radioactive sample





#### **♦ NUCEF**

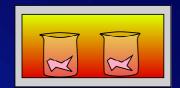
- Radiochemical lab.
- Bulk analysis
- Radioactive sample

# **Environmental sample analysis**



**Cotton cloth** (10x10 cm<sup>2</sup>)

**Bulk Analysis** 

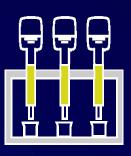


Ashing

Acid

**Acidic Digestion** 

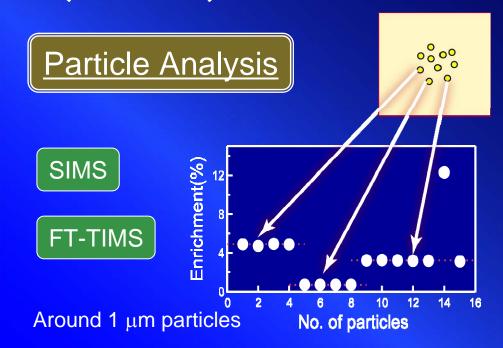
DL for Pu :  $\sim 10 \text{ fg } (10^{-15} \text{ g})$ 



Chemical Separation



To remove matrix elements for accurate isotope ratio measurement



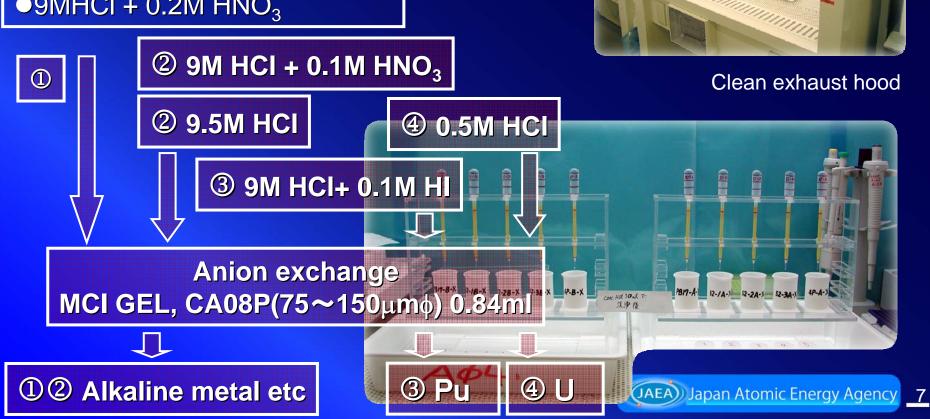


ISO Class 5 Clean room



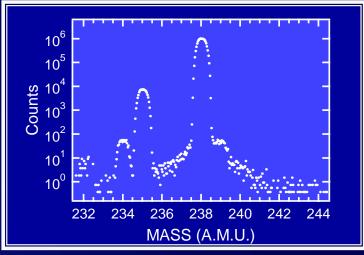
### Chemical separation

- ●15M HNO<sub>3</sub> & Dry up (3 times)
- ●9.5M HCl & Dry up
- ●1M HCI + 3M NH<sub>2</sub>OH•HCI
- Standing for 60 min.
- Dry up slowly
- ●9MHCI + 0.2M HNO<sub>3</sub>



### Isotope ratio measurement





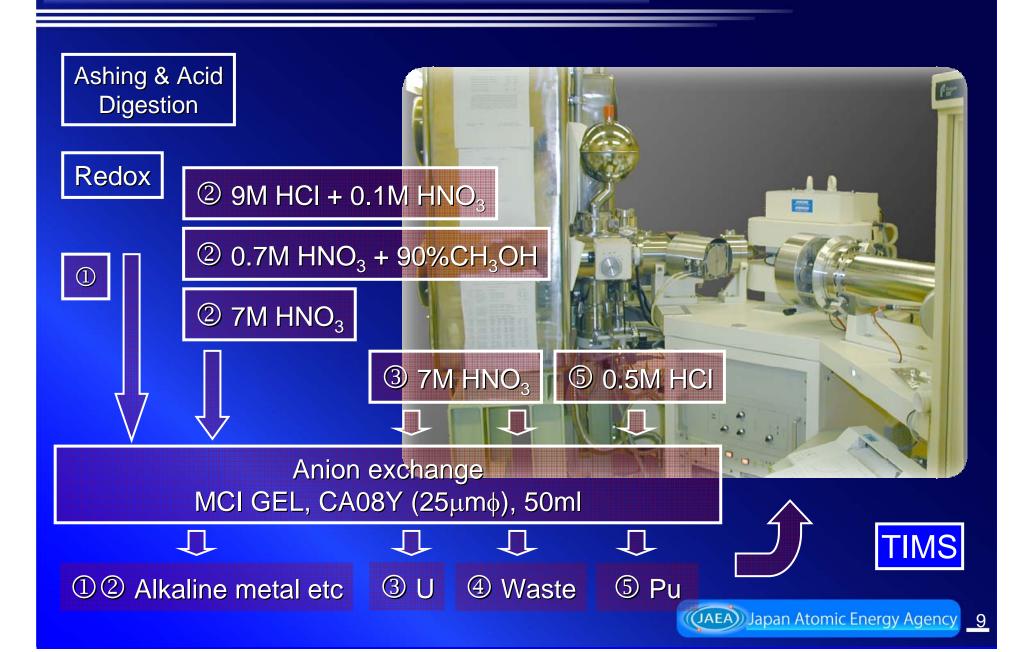
0.32M HNO<sub>3</sub> Solution 1,800 cps / (pg/ml) NU:5 ~ 800 pg/ml(ppt)

Double focus ICP-MS: ELEMENT1

Ion detector: SEM Resolution (M/ $\Delta$ M)= 300

Scan mode: E-Scan

### Bulk analysis (Radioactive sample)



# Particle analysis

**SIMS** method (Routinely used)



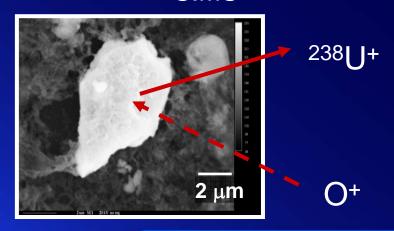
Particle recovery (Vacuum impactor)



Particles collected on planchet



SIMS



#### **Milestones**

- ◆ 2002 November Review at CLEAR
  - Two IAEA experts visited JAEA
  - Analytical results
  - Facility performance(CLEAR/NUCEF)
  - QA/QC
- 2003 January Qualification to IAEA NWAL
- ◆ 2003 February First analysis of domestic samples
- **2004 January** NWAL contract with IAEA
- ◆ 2004 February First analysis of IAEA samples

Sample analysis

28 Swipes/y (Average 2005-2006)

Particle: 33 Swipes/y (Average 2004-2006)

#### **Desolvation module**



**Scott-type spray chamber** Sensitivity: 1.8 Mcps / ppb <sup>238</sup>U

**Bulk analysis** 

**Over 7 times improvement!!** 



**Apex High-efficiency** inlet system

**Sensitivity:** 13 Mcps / ppb <sup>238</sup>U

http://www.elementalscientific.com/products/apex.asp



# Pick-up SIMS method

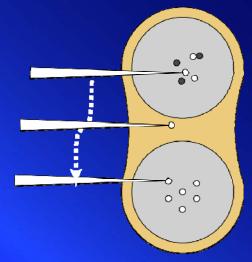
### Particles pick up





Particle recovery (Vacuum impactor)







Scanning electron microscopy (SEM)

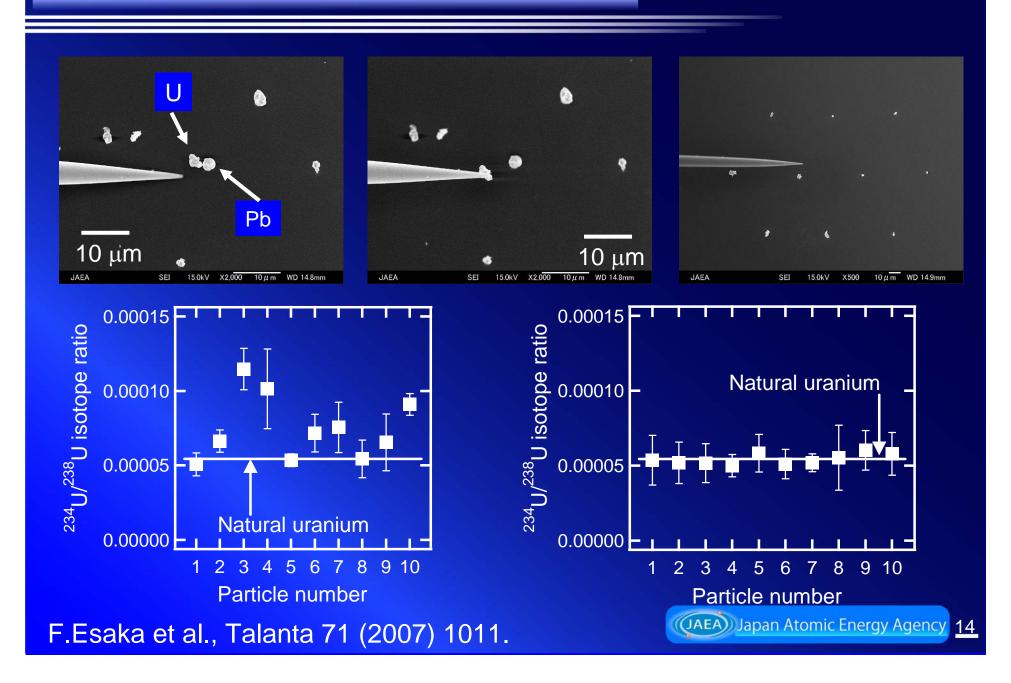


SIMS

Particles pick up and transfer



# Results of pick-up SIMS



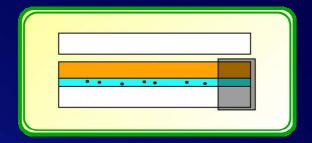
### **FT-TIMS** method



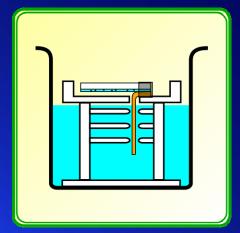
Collect particles on filter



**Neutron irradiation** 



Prepare irradiation sample



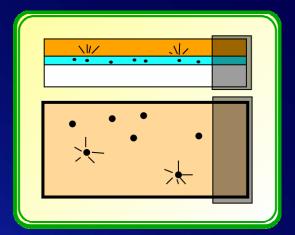
**Etching** 

Accurate method A lot of time to measure



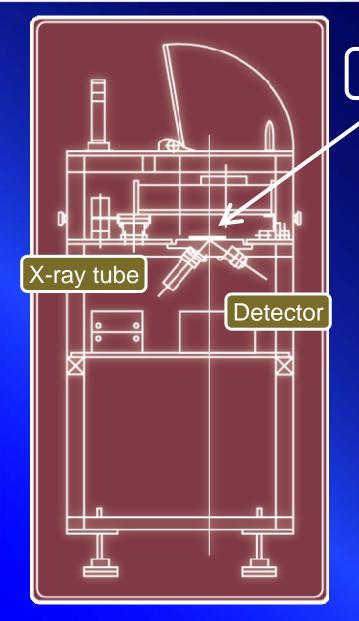


TIMS





# XRF for screening



Swipe sample

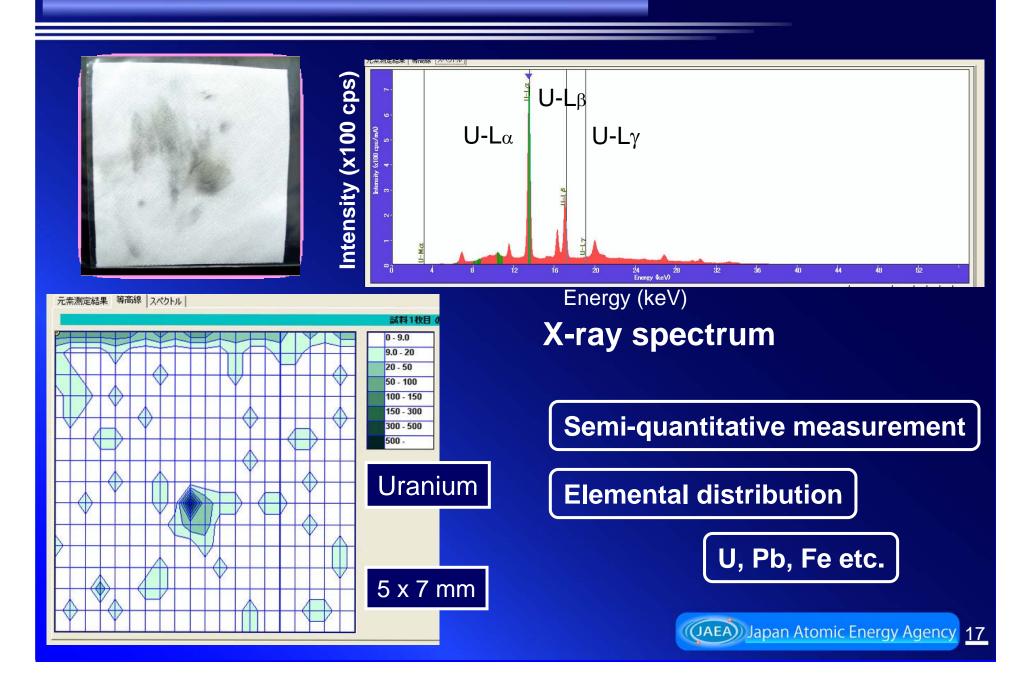
**Uranium amount** 

**Impurity measurement** 

Pb, Fe etc.



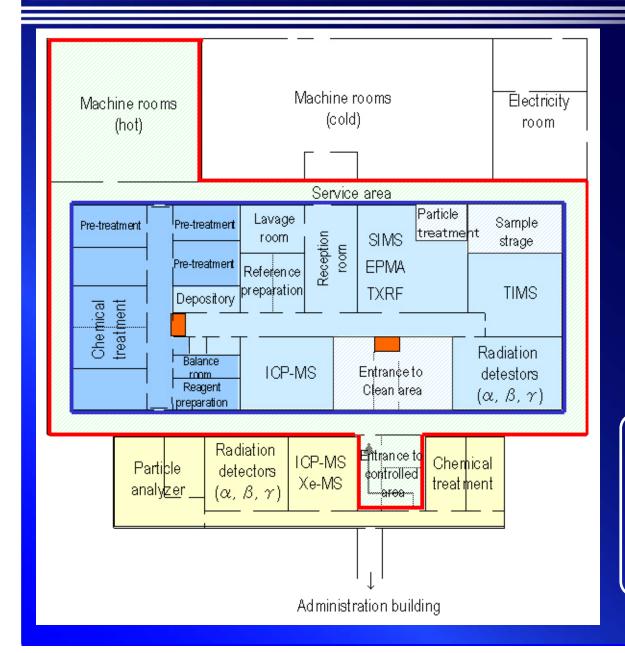
### Results of XRF measurement

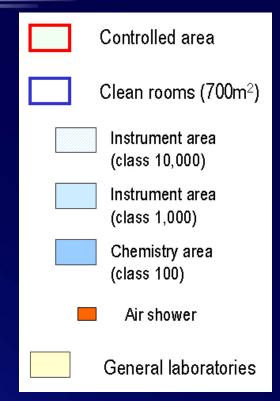


# CLEAR



# CLEAR – Floor plan





Cleanness class is defined as maximum number of particles  $(> 0.5 \mu \text{ m}) \text{ in } 1 \text{ ft}^3.$ No cleanness-controlled rooms, e.g. normal office rooms, sometimes contain the particle more than one million.

# Air flow and pressure control

